

FAN4050

Precision Micropower Shunt Voltage Reference

Features

- Fixed 2.500V, 4.096V, 5.000V, 8.192V, 10.000V
- Tolerances to $\pm 0.1\%$ (25°C)
- · Low output noise
- · Low temperature coefficient
- Small packages: SSOT-23
- · Extended operating current range

Applications

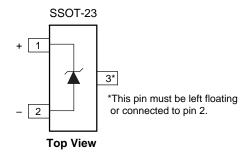
- · Portable equipment
- · Disk drives
- Instrumentation
- · Audio equipment
- Data acquisition systems

Description

The FAN4050 series of precision shunt references are ideal for space- and cost-sensitive applications. They are available in a variety of fixed output voltages (2.500V, 4.096V, 5.000V, 8.192V, and 10.000V) and with a variety of output voltage tolerances (0.1%, 0.2%, and 0.5%). They also have excellent temperature coefficients, 50ppm/°C.

The FAN4050 series is available in the SSOT-23 package.

Connection Diagram



Absolute Maximum Ratings¹

Ratings are over full operating free-air temperature range unless otherwise noted.

Parameter	Min.	Max.	Unit
Continuous cathode current, I _K	-10	20	mA
Power dissipation ²		280	mW
Storage Temperature Range	-65	150	°C
Lead Temperature (Soldering, 10 sec.)		300	°C

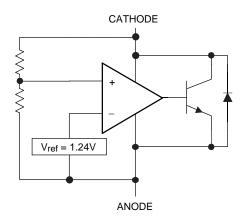
Notes:

- 1. Functional operation under these conditions is not implied. Permanent damage may occur if the device is subjected to conditions outside these ratings.
- 2. It is recommended to connect pin 3 to pin 2 in the SSOT23 package to ensure optimal thermal performance.

Recommended Operating Conditions

Parameter	Min.	Max.	Unit
Continuous cathode current, I _K	0.1	15	mA
Operating temperature range in free air, TA	-40	85	°C

Equivalent Schematic



Guaranteed Electrical Characteristics, FAN4050-2.5

 $(T_A = 25^{\circ}C \text{ unless otherwise specified, in free air)}$

The • denotes specifications which apply over the full operating temperature range.

					Limits		Units
Symbol	Parameter	Conditions		Α	В	С	
V_R	Reverse Breakdown Voltage	I _K = 100μA		2.500	2.500	2.500	V*
TCV _R	Reverse Breakdown Voltage Tolerance	I _K = 100μA	•	±2.5 ±11	±5.0 ±14	±13 ±21	mV mV
I _{RMIN}	Minimum Operating Current		•	65	65	65	μA
$\Delta V_R/\Delta T$	Reverse Breakdown Voltage Temperature Coefficient	I _K = 100μA	•	±50	±50	±50	ppm/°C
$\Delta V_R (\Delta I_K)$	Reverse Breakdown Voltage Change with Operating Current	$I_{RMIN} \le I_K \le 1mA$ $1mA \le I_K \le 15mA$	•	1.2 8.0	1.2 8.0	1.2 8.0	mV mV
Z _{KA}	Reverse Dynamic Impedance	I _K =1mA, f=120Hz, I _{AC} =0.1I _K		0.3	0.3	0.3	Ω*
e _N	Wideband Noise	$I_K=100\mu A$, $10Hz \le f \le 10kHz$		41	41	41	μV _{RMS} *
ΔV_R	Reverse Breakdown Voltage Long-term Stability	t=1000hrs, T=25°C, I _K =100μA		120	120	120	ppm*

^{*}Typical.

Guaranteed Electrical Characteristics, FAN4050-4.1

 $(T_A = 25^{\circ}C \text{ unless otherwise specified, in free air)}$

The • denotes specifications which apply over the full operating temperature range.

					Limits		Units
Symbol	Parameter	Conditions		Α	В	С	
V_{R}	Reverse Breakdown Voltage	I _K = 100μA		4.096	4.096	4.096	V*
TCV _R	Reverse Breakdown Voltage	I _K = 100μA		±4.1	±8.2	±21	mV
	Tolerance		•	±18	±22	±34	mV
I _{RMIN}	Minimum Operating Current		•	73	73	73	μΑ
$\Delta V_R/\Delta T$	Reverse Breakdown Voltage Temperature Coefficient	I _K = 100μA	•	±50	±50	±50	ppm/°C
$\Delta V_R (\Delta I_K)$	Reverse Breakdown Voltage	I _{RMIN} ≤ I _K ≤1mA	•	1.2	1.2	1.2	mV
	Change with Operating Current	$1mA \le I_K \le 15mA$	•	10	10	10	mV
Z _{KA}	Reverse Dynamic Impedance	I _K =1mA, f=120Hz, I _{AC} =0.1I _K		0.5	0.5	0.5	Ω*
e _N	Wideband Noise	$I_K=100\mu A$, $10Hz \le f \le 10kHz$		93	93	93	μV _{RMS} *
ΔV_R	Reverse Breakdown Voltage Long-term Stability	t=1000hrs, T=25°C, I _K =100μA		120	120	120	ppm*

^{*}Typical.

Guaranteed Electrical Characteristics, FAN4050-5.0

 $(T_A = 25^{\circ}C \text{ unless otherwise specified, in free air)}$

The • denotes specifications which apply over the full operating temperature range.

					Limits		Units
Symbol	Parameter	Conditions		Α	В	С	
V_{R}	Reverse Breakdown Voltage	I _K = 100μA		5.000	5.000	5.000	V*
TCV _R	Reverse Breakdown Voltage	I _K = 100μA		±5.0	±10	±25	mV
	Tolerance		•	±22	±27	±42	mV
I _{RMIN}	Minimum Operating Current		•	80	80	80	μΑ
$\Delta V_R/\Delta T$	Reverse Breakdown Voltage Temperature Coefficient	I _K = 100μA	•	±50	±50	±50	ppm/°C
$\Delta V_R (\Delta I_K)$	Reverse Breakdown Voltage	I _{RMIN} ≤ I _K ≤1mA	•	1.4	1.4	1.4	mV
	Change with Operating Current	$1mA \le I_K \le 15mA$	•	12	12	12	mV
Z _{KA}	Reverse Dynamic Impedance	I_K =1mA, f=120Hz, I_{AC} =0.1 I_K		0.5	0.5	0.5	Ω^*
e _N	Wideband Noise	I_{K} =100 μ A, 10Hz \leq f \leq 10kHz		93	93	93	μV _{RMS} *
ΔV_{R}	Reverse Breakdown Voltage Long-term Stability	t=1000hrs, T=25°C, I _K =100μA		120	120	120	ppm*

^{*}Typical.

Guaranteed Electrical Characteristics, FAN4050-8.2

 $(T_A = 25^{\circ}C \text{ unless otherwise specified, in free air)}$

The • denotes specifications which apply over the full operating temperature range.

					Limits		Units
Symbol	Parameter	Conditions		Α	В	С	
V_{R}	Reverse Breakdown Voltage	I _K = 150μA		8.192	8.192	8.192	V*
TCV _R	Reverse Breakdown Voltage Tolerance	I _K = 150μA	•	±8.2 ±35	±16 ±43	±41 ±68	mV mV
I _{RMIN}	Minimum Operating Current		•	95	95	95	μA
$\Delta V_R/\Delta T$	Reverse Breakdown Voltage Temperature Coefficient	I _K = 150μA	•	±50	±50	±50	ppm/°C
$\Delta V_R (\Delta I_K)$	Reverse Breakdown Voltage Change with Operating Current	$I_{RMIN} \le I_K \le 1mA$ $1mA \le I_K \le 15mA$	•	2.5 18	2.5 18	2.5 18	mV mV
Z _{KA}	Reverse Dynamic Impedance	I _K =1mA, f=120Hz, I _{AC} =0.1I _K		0.6	0.6	0.6	Ω*
e _N	Wideband Noise	$I_{K}=150\mu A$, 10Hz $\leq f \leq 10kHz$		150	150	150	µV _{RMS} *
ΔV_{R}	Reverse Breakdown Voltage Long-term Stability	t=1000hrs, T=25°C, I _K =150µA		120	120	120	ppm*

^{*}Typical.

Guaranteed Electrical Characteristics, FAN4050-10

 $(T_A = 25^{\circ}C \text{ unless otherwise specified, in free air})$ The \bullet denotes specifications which apply over the full operating temperature range.

					Limits		Units
Symbol	Parameter	Conditions		Α	В	С	
V_{R}	Reverse Breakdown Voltage	I _K = 150μA		10.00	10.00	10.00	V*
TCV _R	Reverse Breakdown Voltage Tolerance	I _K = 150μA	•	±10 ±43	±20 ±53	±50 ±83	mV mV
I _{RMIN}	Minimum Operating Current		•	103	103	103	μΑ
$\Delta V_R/\Delta T$	Reverse Breakdown Voltage Temperature Coefficient	I _K = 150μA	•	±50	±50	±50	ppm/°C
$\Delta V_R (\Delta I_K)$	Reverse Breakdown Voltage Change with Operating Current	$I_{RMIN} \le I_K \le 1mA$ $1mA \le I_K \le 15mA$	•	3.5 23	3.5 23	3.5 23	mV mV
Z _{KA}	Reverse Dynamic Impedance	I _K =1mA, f=120Hz, I _{AC} =0.1I _K		0.7	0.7	0.7	Ω*
e _N	Wideband Noise	I_{K} =150 μ A, 10Hz \leq f \leq 10kHz		150	150	150	μV _{RMS} *
ΔV_R	Reverse Breakdown Voltage Long-term Stability	t=1000hrs, T=25°C, I _K =150μA		120	120	120	ppm*

^{*}Typical.

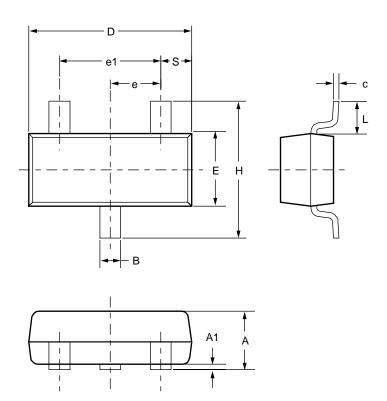
Mechanical Dimensions

SSOT-23 Package

Cumbal	Inc	hes	Millin	Notes	
Symbol	Min.	Max.	Min.	Max.	Notes
А	.035	.044	.89	1.02	
A1	.0005	.004	.013	.10	
В	.015	.020	.37	.51	
С	.003	.007	.085	.18	
D	.110	.120	2.80	3.04	
E	.047	.055	1.20	1.40	
е	.035	.041	.89	1.03	
e1	.070	.080	1.78	2.05	
Н	.083	.104	2.10	2.10 2.64	
L	.027	BSC	.69		
S	.018	.024	.45	.45 .60	

Notes:

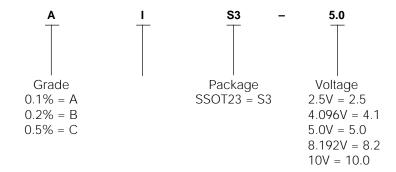
- 1. Dimensions are inclusive of plating.
- 2. Dimensions are exclusive of mold flash & metal burr.
- 3. Comply to JEDEC TO-236.
- 4. This drawing is for matrix leadframe only.



Ordering Information

Example: FAN4050 A I S3-5.0

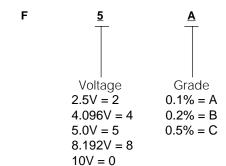
FAN4050



SSOT-23 Package Marking Information

Only 3 fields of marking are possible on an SSOT-23. This table gives the meaning of these fields.

Example: F5A



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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
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